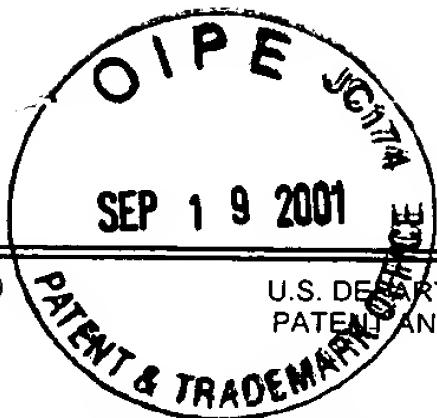


Form PTO 1449 (Revised) PATENT & TRADEMARK OFFICE		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 210241US0		SERIAL NO. 09/886,256	
		LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Masaaki MAWATARI, et al.			
				FILING DATE June 22, 2001		GROUP 1714	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>AW</i>	AO	0 388 942	09/26/90	EUROPE	<input checked="" type="checkbox"/>		
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
<i>AW</i>	AV	Derwent Publications, AN 2000-298678/26, JP 2000-086887, March 28, 2000					
<i>AW</i>	AW	Patent Abstracts of Japan, JP 61-188459, August 22, 1986					
<i>AW</i>	AX	Derwent Publications, AN 94-115362/14, JP 06-065502, March 8, 1994					
<i>AW</i>	AY	Patent Abstracts of Japan, JP 3-273058, December 4, 1991					
<i>AW</i>	AZ	Derwent Publications, AN 92-027488/04, JP 3-273058, December 4, 1991				<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>[Signature]</i>				Date Considered <i>3/2003</i>			
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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Masaaki MAWATARI, et al.

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
<i>AO</i>	AO	7-228773	08/29/95	JAPAN (with English Abstract)		X
<i>AP</i>	AP	7-228775	08/29/95	JAPAN (with English Abstract)		X
<i>AQ</i>	AQ	11-241019	09/07/99	JAPAN (with English Abstract)		X
<i>AR</i>	AR	11-241020	09/07/99	JAPAN (with English Abstract)		X
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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	AX	
	AY	
	AZ	

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